

Search Notes

Application/Control No.

10/627,469

Examiner

Nhan T. Tran

Applicant(s)/Patent under
Reexamination

BRONSTEIN ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
348	239; 231.2	7/2/2007	NT
348	211.2	7/6/2007	NT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	7/2/2007	NT
348/231.2-231.9 (text search - see search history printout)	7/2/2007	NT
Text search all databases listed above	7/3/2007	NT